

Notice of References Cited	Application/Control No. 10/080,121	Applicant(s)/Patent Under Reexamination WAKISAKA ET AL.	
	Examiner <i>QML 4-af</i> Quyen P. Leung	Art Unit 2828	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,338,577	07-1982	Sato et al.	372/36
*	B	US-6,219,364	04-2001	Dei, Yoshihiro	372/36
*	C	US-6,359,330	03-2002	Goudard, Jean-Luc	257/678
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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